

MOSFET

PowerStage 3x3

Features

- Dual N-channel OptiMOS™ MOSFET
- Enhancement mode
- Logic level (4.5V rated)
- Avalanche rated
- 100% Lead-free; RoHS compliant
- Halogen-free according to IEC61249-2-21

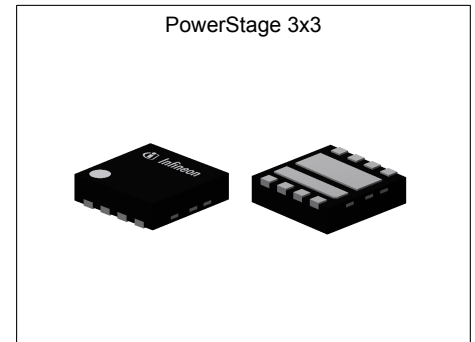
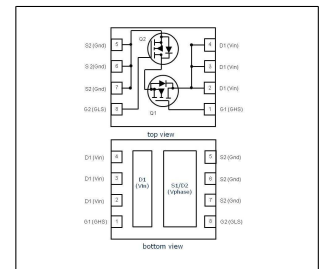


Table 1 Key Performance Parameters

| Parameter | Value | Unit |
|------------------|-------|------------|
| V_{DS} | 30 | V |
| $R_{DS(on),max}$ | 18 | m Ω |
| I_D | 20 | A |
| Q_{OSS} | 2.3 | nC |
| $Q_G(0V..4.5V)$ | 1.8 | nC |



| Type / Ordering Code | Package | Marking | Related Links |
|----------------------|------------|---------|---------------|
| BSZ0909ND | PG-WISON-8 | 0909ND | - |

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1 Maximum ratings

at $T_j=25\text{ °C}$, unless otherwise specified, one transistor active

Table 2 Maximum ratings

| Parameter | Symbol | Values | | | Unit | Note / Test Condition |
|------------------------------------|-------------------|--------|-----------|-------------------------|------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| | | Min. | Typ. | Max. | | |
| Continuous drain current | I_D | - | - | 20 8.1 5.5 4.1 | A | $V_{GS}=10\text{ V}$, $T_C=25\text{ °C}$ $V_{GS}=10\text{ V}$, $T_A=25\text{ °C}^{1)}$ $V_{GS}=4.5\text{ V}$, $T_A=70\text{ °C}^{1)}$ $V_{GS}=4.5\text{ V}$, $T_A=25\text{ °C}^{2)}$ |
| Pulsed drain current ³⁾ | $I_{D,pulse}$ | - | - | 40 | A | $T_C=25\text{ °C}$ |
| Avalanche energy, single pulse | E_{AS} | - | - | 4 | mJ | $I_D=9\text{ A}$, $R_{GS}=25\text{ }\Omega$ |
| Gate source voltage | V_{GS} | -20 | - | 20 | V | - |
| Power dissipation | P_{tot} | - | 17 1.9 | - | W | $T_C=25\text{ °C}$ $T_A=25\text{ °C}$, $R_{thJA}=65\text{ °C/W}^{1)}$ |
| Operating and storage temperature | T_j , T_{stg} | -55 | - | 150 | °C | IEC climatic category; DIN IEC 68-1: 55/150/56 |

2 Thermal characteristics

Table 3 Thermal characteristics

| Parameter | Symbol | Values | | | Unit | Note / Test Condition |
|--------------------------------------------------|------------|--------|------|------|------|-----------------------|
| | | Min. | Typ. | Max. | | |
| Thermal resistance, junction - case | R_{thJC} | - | - | 7.5 | °C/W | - |
| Device on PCB, minimal footprint | R_{thJA} | - | - | 180 | °C/W | - |
| Device on PCB, 6 cm ² cooling area | R_{thJA} | - | - | 65 | °C/W | - |

¹⁾ Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm² (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

²⁾ device mounted on a minimum pad (one layer, 70 µm thick)

³⁾ See Diagram 3 for more detailed information

3 Electrical characteristics

Table 4 Static characteristics

| Parameter | Symbol | Values | | | Unit | Note / Test Condition |
|----------------------------------|---------------|--------|------------|----------|------------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------|
| | | Min. | Typ. | Max. | | |
| Drain-source breakdown voltage | $V_{(BR)DSS}$ | 30 | - | - | V | $V_{GS}=0\text{ V}$, $I_D=1\text{ mA}$ |
| Gate threshold voltage | $V_{GS(th)}$ | 1.2 | 1.6 | 2 | V | $V_{DS}=V_{GS}$, $I_D=250\text{ }\mu\text{A}$ |
| Zero gate voltage drain current | I_{DSS} | - | - | 1 100 | μA | $V_{DS}=30\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=25\text{ }^\circ\text{C}$ $V_{DS}=30\text{ V}$, $V_{GS}=0\text{ V}$, $T_j=150\text{ }^\circ\text{C}$ |
| Gate-source leakage current | I_{GSS} | - | - | 100 | nA | $V_{GS}=20\text{ V}$, $V_{DS}=0\text{ V}$ |
| Drain-source on-state resistance | $R_{DS(on)}$ | - | 20 14.5 | 25 18 | $\text{m}\Omega$ | $V_{GS}=4.5\text{ V}$, $I_D=9\text{ A}$ $V_{GS}=10\text{ V}$, $I_D=9\text{ A}$ |
| Gate resistance ¹⁾ | R_G | 3.5 | 7 | 14 | Ω | - |
| Transconductance | g_{fs} | - | 22 | - | S | $ V_{DS} >2 I_D R_{DS(on)max}$, $I_D=9\text{ A}$ |

Table 5 Dynamic characteristics

| Parameter | Symbol | Values | | | Unit | Note / Test Condition |
|----------------------------------|--------------|--------|------|------|------|-------------------------------------------------------------------------------------------------|
| | | Min. | Typ. | Max. | | |
| Input capacitance ¹⁾ | C_{iss} | - | 270 | 360 | pF | $V_{GS}=0\text{ V}$, $V_{DS}=15\text{ V}$, $f=1\text{ MHz}$ |
| Output capacitance ¹⁾ | C_{oss} | - | 88 | 120 | pF | $V_{GS}=0\text{ V}$, $V_{DS}=15\text{ V}$, $f=1\text{ MHz}$ |
| Reverse transfer capacitance | C_{rss} | - | 11 | - | pF | $V_{GS}=0\text{ V}$, $V_{DS}=15\text{ V}$, $f=1\text{ MHz}$ |
| Turn-on delay time | $t_{d(on)}$ | - | 5 | - | ns | $V_{DD}=15\text{ V}$, $V_{GS}=10\text{ V}$, $I_D=9\text{ A}$, $R_{G,ext}=6\text{ }\Omega$ |
| Rise time | t_r | - | 2.5 | - | ns | $V_{DD}=15\text{ V}$, $V_{GS}=10\text{ V}$, $I_D=9\text{ A}$, $R_{G,ext}=6\text{ }\Omega$ |
| Turn-off delay time | $t_{d(off)}$ | - | 15 | - | ns | $V_{DD}=15\text{ V}$, $V_{GS}=10\text{ V}$, $I_D=9\text{ A}$, $R_{G,ext}=6\text{ }\Omega$ |
| Fall time | t_f | - | 2 | - | ns | $V_{DD}=15\text{ V}$, $V_{GS}=10\text{ V}$, $I_D=9\text{ A}$, $R_{G,ext}=6\text{ }\Omega$ |

Table 6 Gate charge characteristics²⁾

| Parameter | Symbol | Values | | | Unit | Note / Test Condition |
|------------------------------|---------------|--------|------|------|------|-----------------------------------------------------------------------------|
| | | Min. | Typ. | Max. | | |
| Gate to source charge | Q_{gs} | - | 0.8 | - | nC | $V_{DD}=15\text{ V}$, $I_D=9\text{ A}$, $V_{GS}=0\text{ to }4.5\text{ V}$ |
| Gate charge at threshold | $Q_{g(th)}$ | - | 0.4 | - | nC | $V_{DD}=15\text{ V}$, $I_D=9\text{ A}$, $V_{GS}=0\text{ to }4.5\text{ V}$ |
| Gate to drain charge | Q_{gd} | - | 0.5 | - | nC | $V_{DD}=15\text{ V}$, $I_D=9\text{ A}$, $V_{GS}=0\text{ to }4.5\text{ V}$ |
| Switching charge | Q_{sw} | - | 0.8 | - | nC | $V_{DD}=15\text{ V}$, $I_D=9\text{ A}$, $V_{GS}=0\text{ to }4.5\text{ V}$ |
| Gate charge total | Q_g | - | 1.8 | 2.6 | nC | $V_{DD}=15\text{ V}$, $I_D=9\text{ A}$, $V_{GS}=0\text{ to }4.5\text{ V}$ |
| Gate plateau voltage | $V_{plateau}$ | - | 2.8 | - | V | $V_{DD}=15\text{ V}$, $I_D=9\text{ A}$, $V_{GS}=0\text{ to }4.5\text{ V}$ |
| Gate charge total | Q_g | - | 3.7 | 5.2 | nC | $V_{DD}=15\text{ V}$, $I_D=9\text{ A}$, $V_{GS}=0\text{ to }10\text{ V}$ |
| Gate charge total, sync. FET | $Q_{g(sync)}$ | - | 1.5 | - | nC | $V_{DS}=0.1\text{ V}$, $V_{GS}=0\text{ to }4.5\text{ V}$ |
| Output charge | Q_{oss} | - | 2.3 | - | nC | $V_{DD}=15\text{ V}$, $V_{GS}=0\text{ V}$ |

¹⁾ Defined by design. Not subject to production test.

²⁾ See "Gate charge waveforms" for parameter definition

Table 7 Reverse diode

| Parameter | Symbol | Values | | | Unit | Note / Test Condition |
|----------------------------------|---------------|--------|------|------|------|---------------------------------------------------------------------|
| | | Min. | Typ. | Max. | | |
| Diode continuous forward current | I_S | - | - | 17 | A | $T_C=25\text{ °C}$ |
| Diode pulse current | $I_{S,pulse}$ | - | - | 40 | A | $T_C=25\text{ °C}$ |
| Diode forward voltage | V_{SD} | - | 0.92 | 1.2 | V | $V_{GS}=0\text{ V}, I_F=9\text{ A}, T_j=25\text{ °C}$ |
| Reverse recovery charge | Q_{rr} | - | 5 | - | nC | $V_R=15\text{ V}, I_F=9\text{ A}, di_F/dt=400\text{ A}/\mu\text{s}$ |

4 Electrical characteristics diagrams

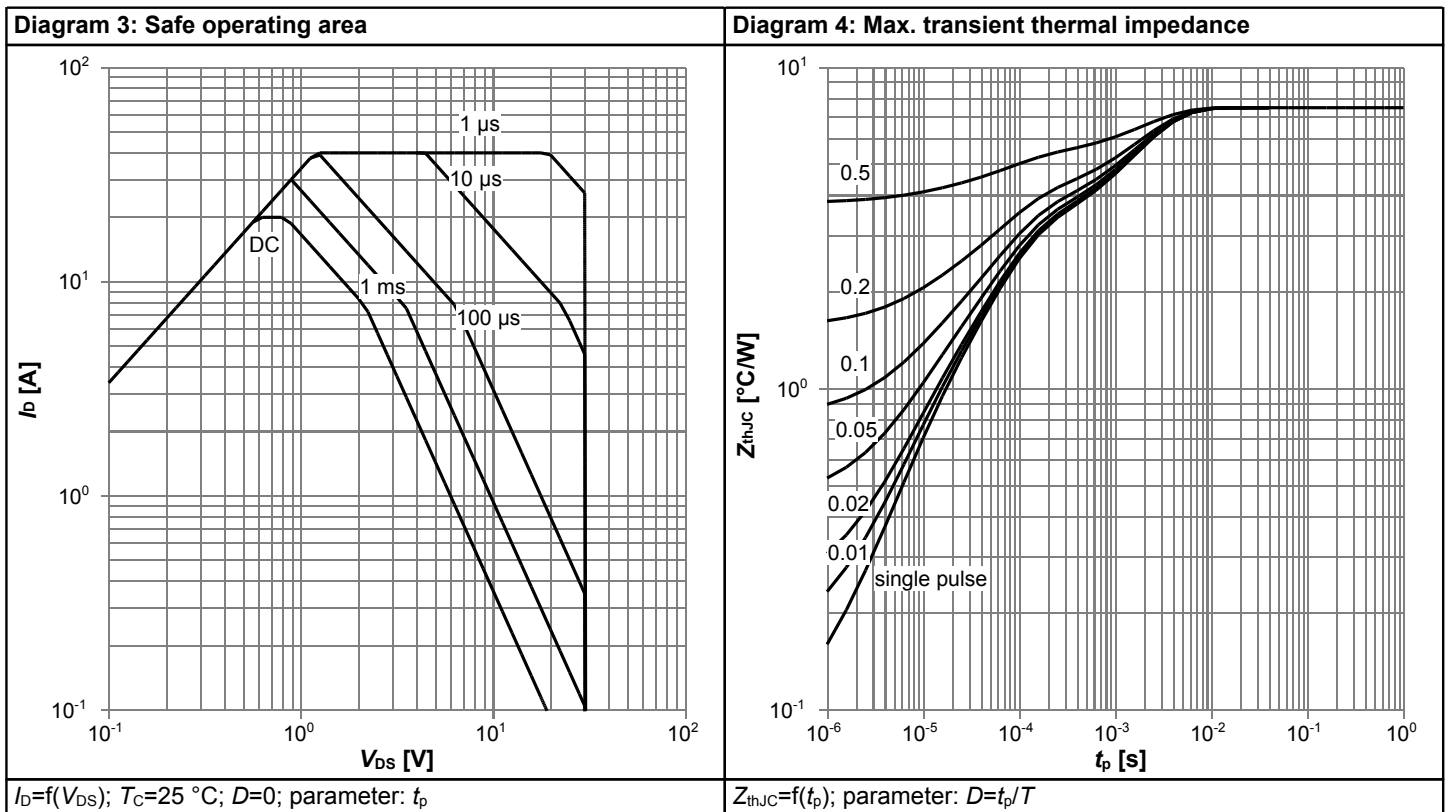
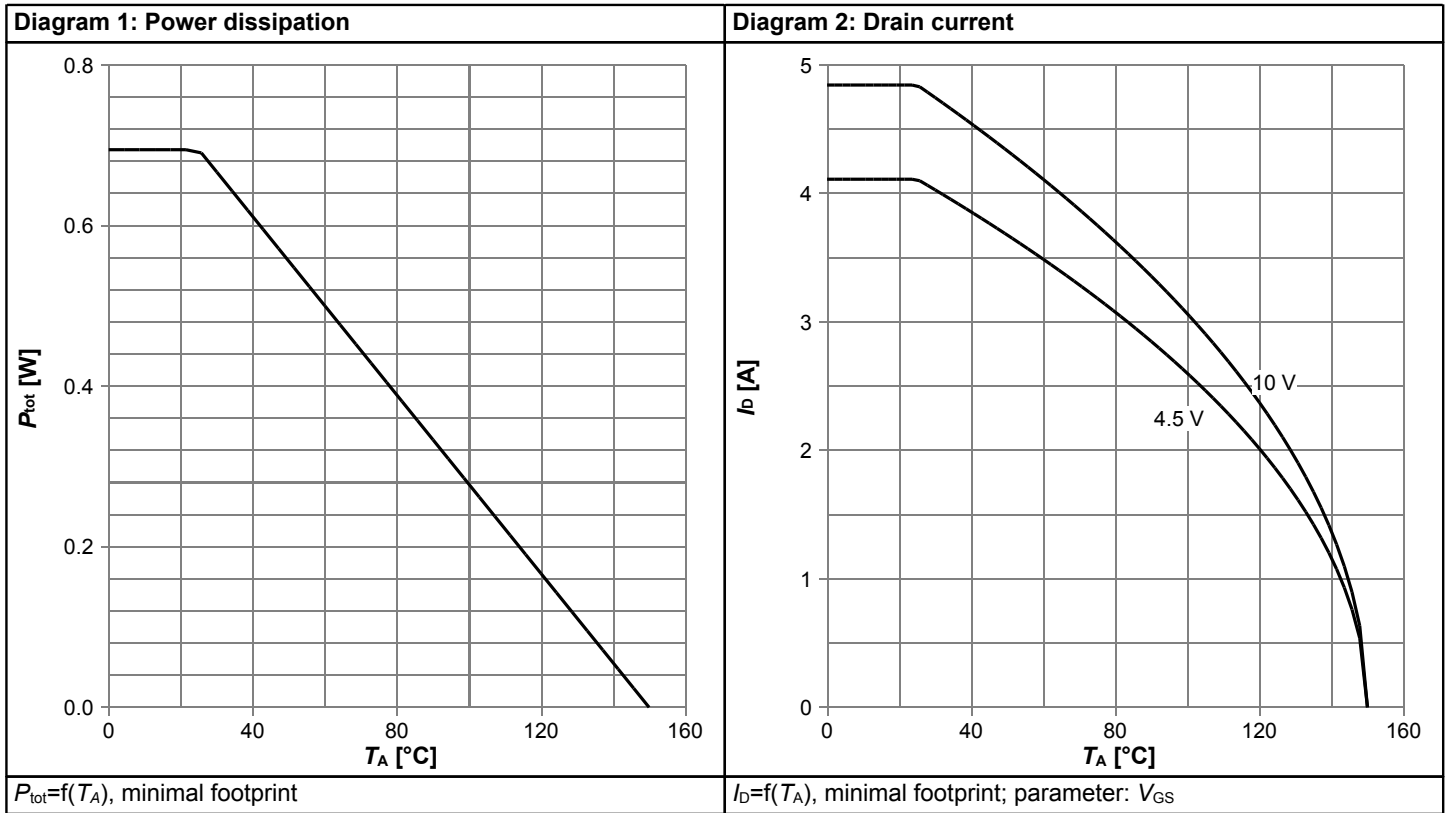
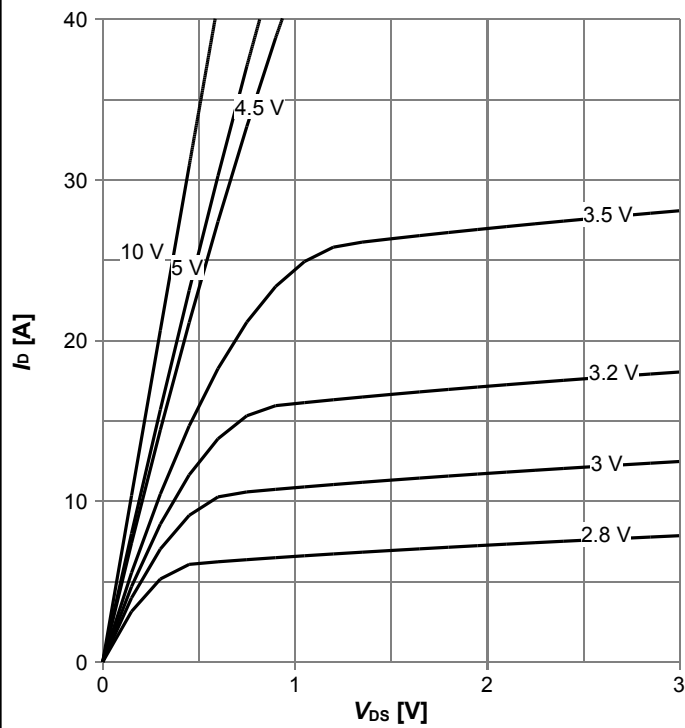
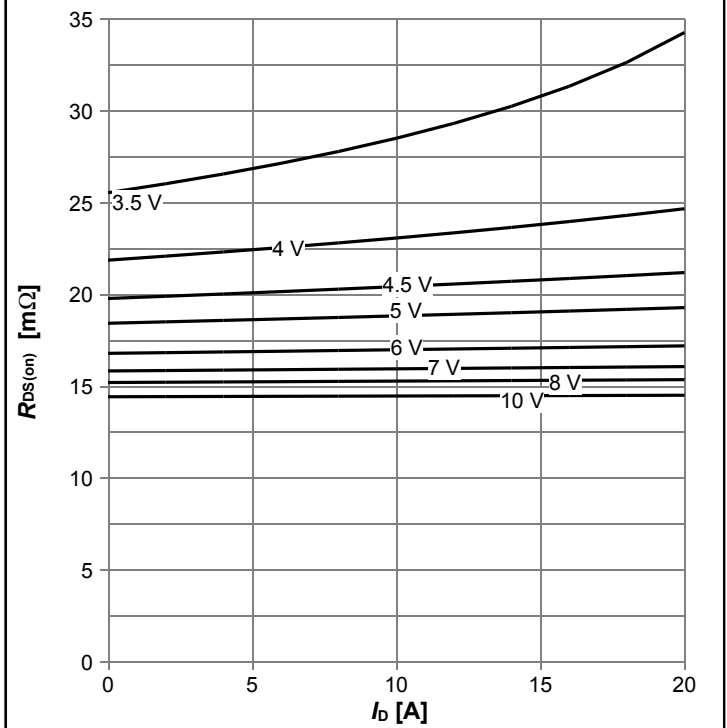


Diagram 5: Typ. output characteristics



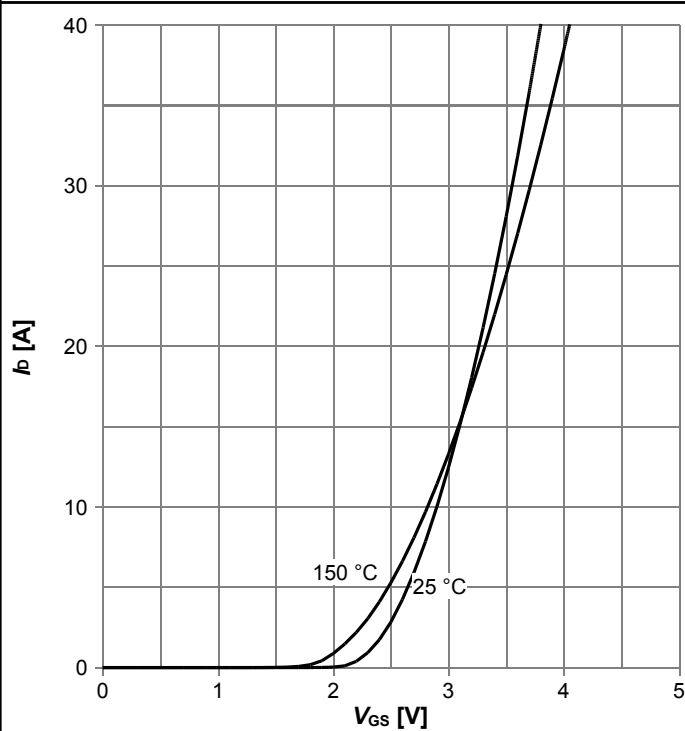
$I_D = f(V_{DS}); T_j = 25\text{ °C}; \text{parameter: } V_{GS}$

Diagram 6: Typ. drain-source on resistance



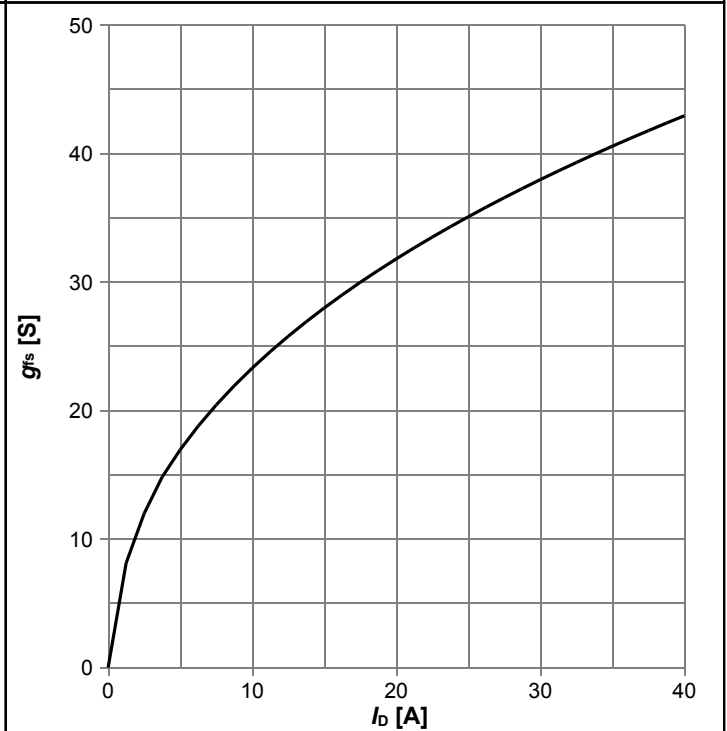
$R_{DS(on)} = f(I_D); T_j = 25\text{ °C}; \text{parameter: } V_{GS}$

Diagram 7: Typ. transfer characteristics



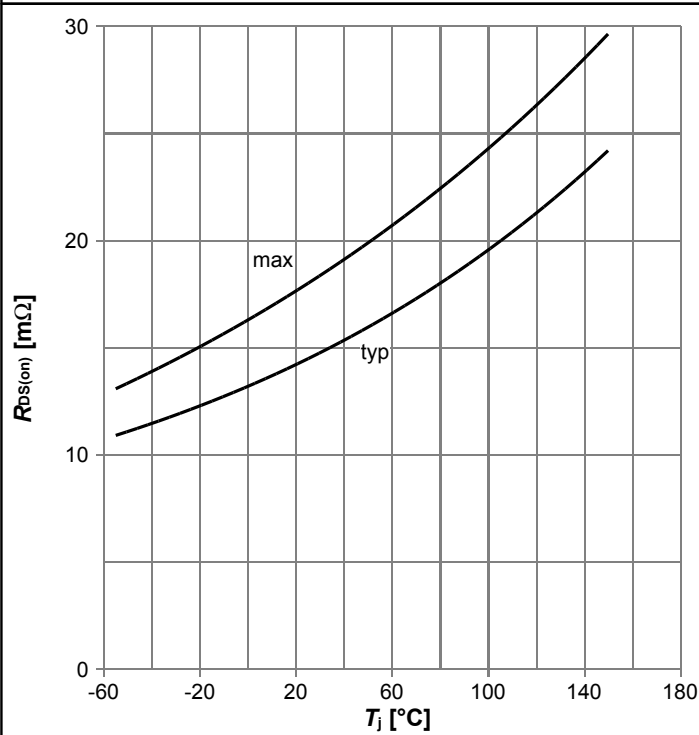
$I_D = f(V_{GS}); |V_{DS}| > 2|I_D|R_{DS(on)max}; \text{parameter: } T_j$

Diagram 8: Typ. forward transconductance



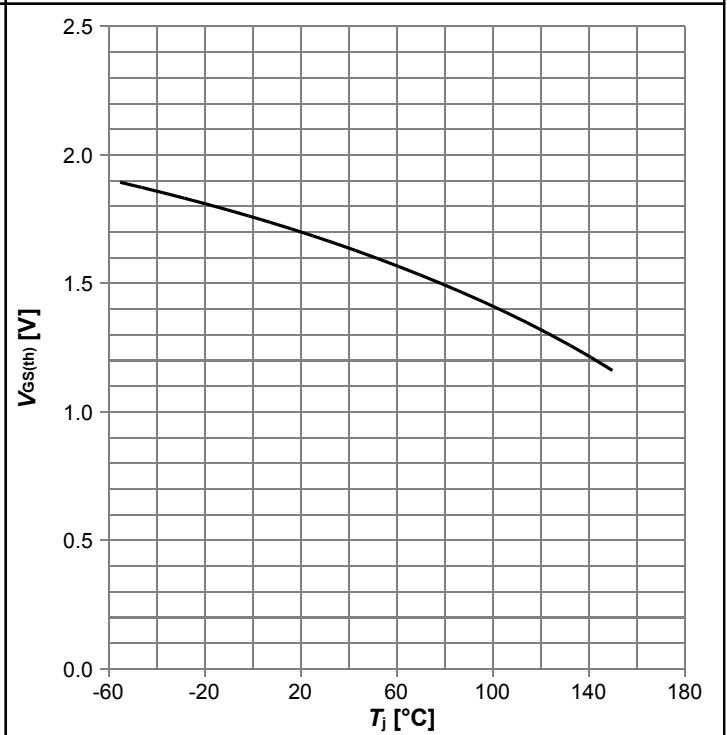
$g_{fs} = f(I_D); T_j = 25\text{ °C}$

Diagram 9: Drain-source on-state resistance



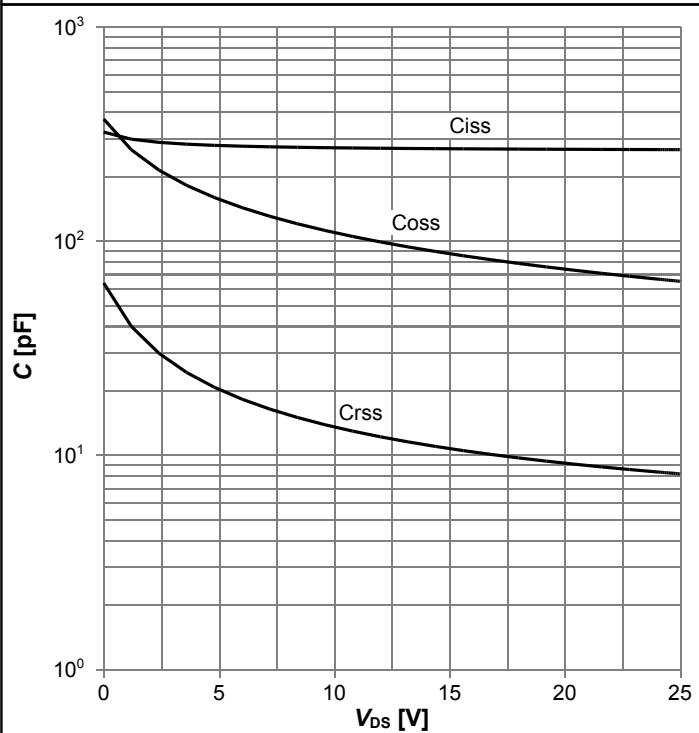
$R_{DS(on)}=f(T_j)$; $I_D=9$ A; $V_{GS}=10$ V

Diagram 10: Typ. gate threshold voltage



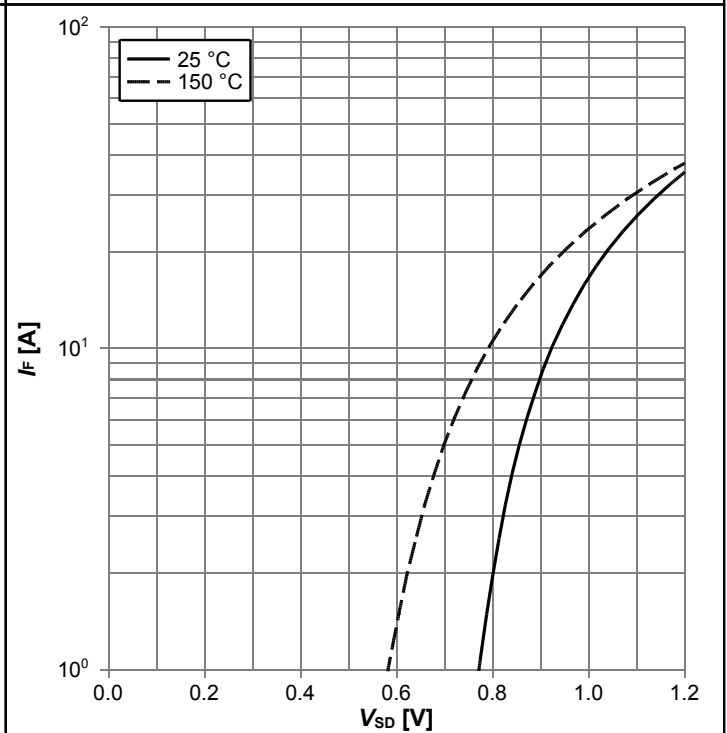
$V_{GS(th)}=f(T_j)$; $V_{GS}=V_{DS}$; $I_D=250$ μ A

Diagram 11: Typ. capacitances



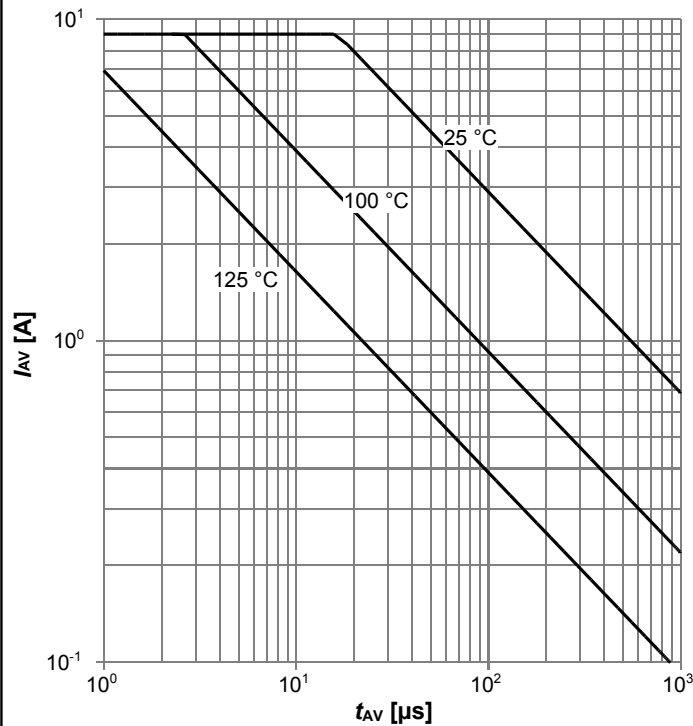
$C=f(V_{DS})$; $V_{GS}=0$ V; $f=1$ MHz

Diagram 12: Forward characteristics of reverse diode



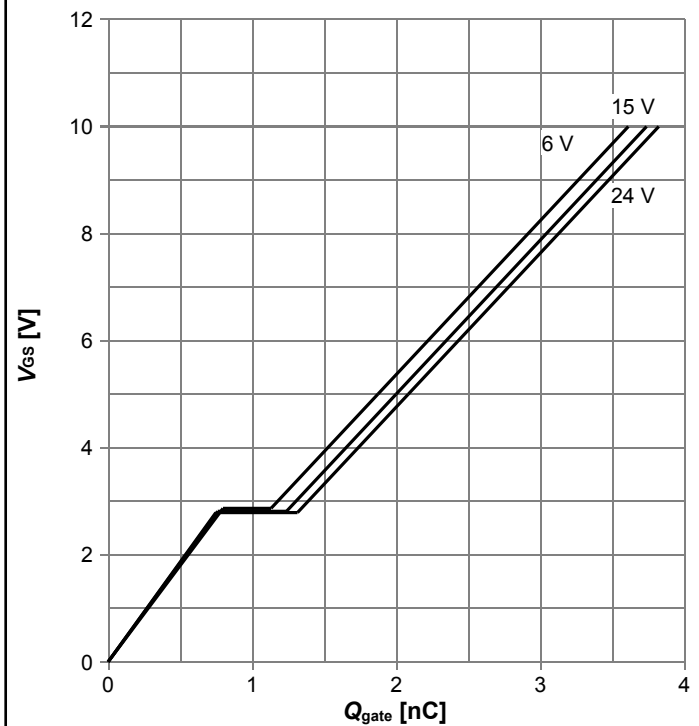
$I_F=f(V_{SD})$; parameter: T_j

Diagram 13: Avalanche characteristics



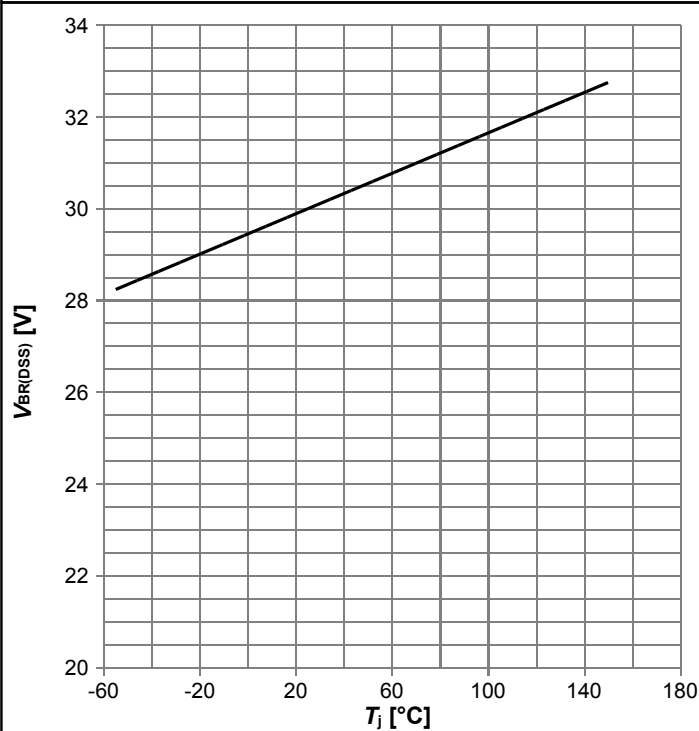
$I_{AS}=f(t_{AV}); R_{GS}=25 \Omega$; parameter: $T_{j(start)}$

Diagram 14: Typ. gate charge



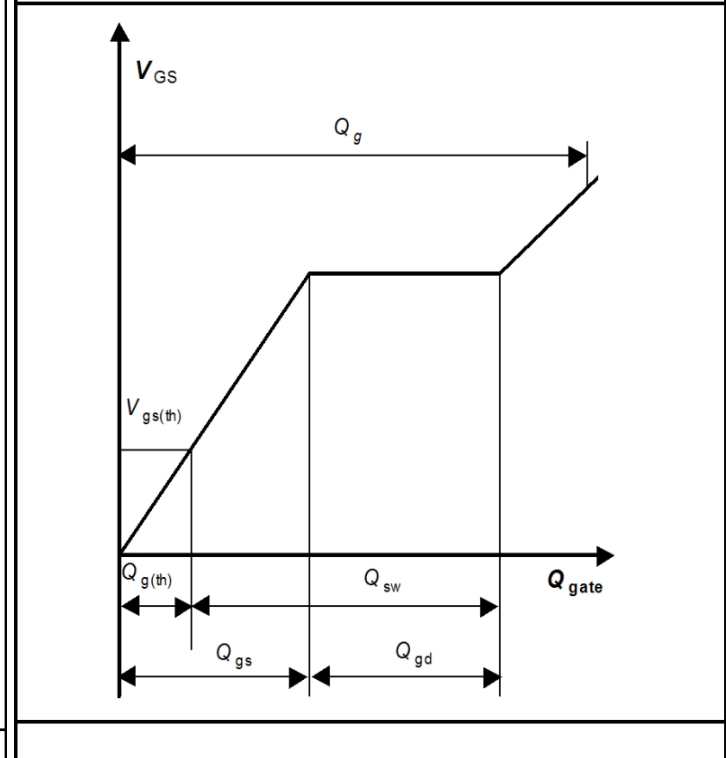
$V_{GS}=f(Q_{gate}); I_D=9$ A pulsed; parameter: V_{DD}

Diagram 15: Drain-source breakdown voltage

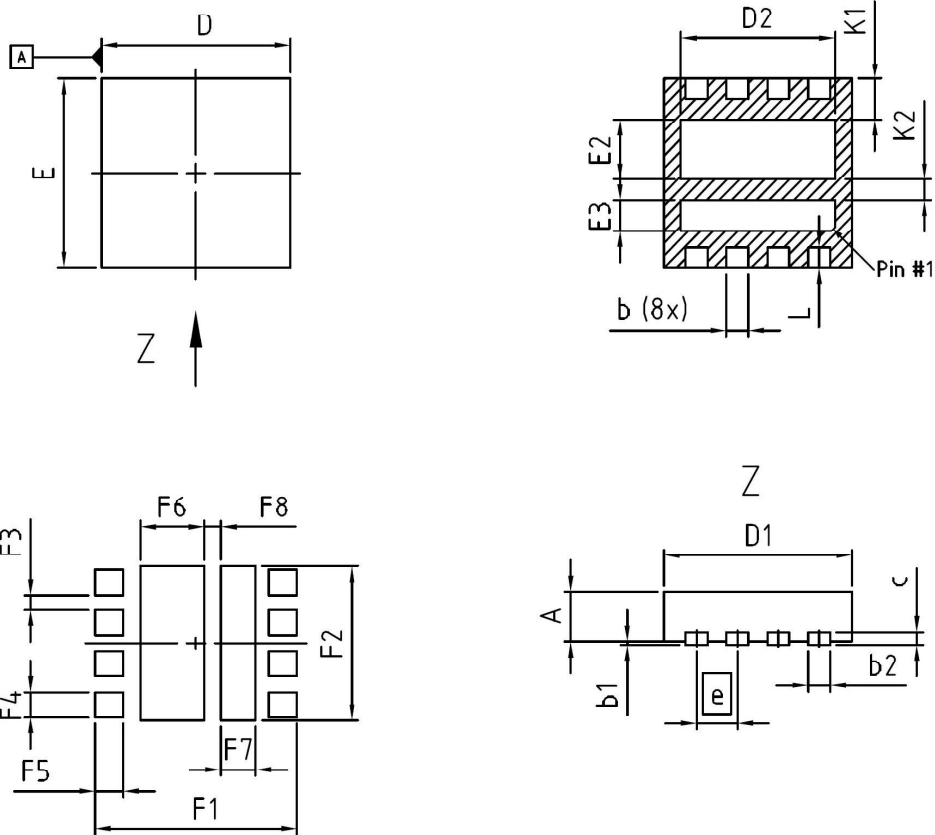


$V_{BR(DSS)}=f(T_j); I_D=1$ mA

Gate charge waveforms



5 Package Outlines



| DIM | MILLIMETERS | | INCHES | |
|------|-------------|------|-------------|-------|
| | MIN | MAX | MIN | MAX |
| A | 0.70 | 0.90 | 0.028 | 0.035 |
| b | 0.25 | 0.45 | 0.010 | 0.018 |
| b1 | 0.00 | 0.05 | 0.000 | 0.002 |
| b2 | 0.25 | 0.45 | 0.010 | 0.018 |
| c | 0.10 | 0.30 | 0.004 | 0.012 |
| D=D1 | 2.90 | 3.10 | 0.114 | 0.122 |
| D2 | 2.35 | 2.55 | 0.093 | 0.100 |
| E=E1 | 2.90 | 3.10 | 0.114 | 0.122 |
| E2 | 0.85 | 1.05 | 0.033 | 0.041 |
| E3 | 0.39 | 0.59 | 0.015 | 0.023 |
| K1 | 0.55 | 0.75 | 0.022 | 0.030 |
| K2 | 0.23 | 0.43 | 0.009 | 0.017 |
| e | 0.65 (BSC) | | 0.026 (BSC) | |
| N | 8 | | 8 | |
| L | 0.22 | 0.42 | 0.009 | 0.017 |
| F1 | 3.21 | | 0.126 | |
| F2 | 2.45 | | 0.096 | |
| F3 | 0.25 | | 0.010 | |
| F4 | 0.40 | | 0.016 | |
| F5 | 0.45 | | 0.018 | |
| F6 | 1.01 | | 0.040 | |
| F7 | 0.55 | | 0.022 | |
| F8 | 0.27 | | 0.011 | |

| |
|------------------------------------|
| DOCUMENT NO. Z8B00158767 |
| SCALE 0 2.5 5mm |
| EUROPEAN PROJECTION |
| ISSUE DATE 15-09-2010 |
| REVISION 01 |

Figure 1 Outline PG-WISON-8, dimensions in mm/inches

Revision History

BSZ0909ND

Revision: 2016-12-05, Rev. 2.0

Previous Revision

| Revision | Date | Subjects (major changes since last revision) |
|----------|------------|----------------------------------------------|
| 2.0 | 2016-12-05 | Release of final version |

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